IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

Wayne G. Renken

Title:

Process Condition Sensing Wafer and Data Analysis System

Application No.:

10/685,550

Filing Date:

October 14, 2003

Examiner:

Samir M. Shah

Group Art Unit:

2856

Docket No.:

SENS.005US1

Conf. No.:

4924

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

RESPONSE TO OFFICE ACTION AND AMENDMENT

Sir:

This is in response to the non-final Office Action dated September 25, 2006, setting a shortened statutory period for response to expire December 25, 2006.

Claim Amendments are reflected in the listing of claims, which begins on page 2 of this paper.

Remarks begin on page 5 of this paper.

Reconsideration is kindly requested in light of the following remarks.

Attorney Docket No.: SENS.005US1

FILED VIA EFS

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